Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	•
10/726,709	MATSUBAYASHI ET AL.	
Examiner	Art Unit	
Le Nguyen	2174	

SEARCHED					
Class	Subclass	Date	Examiner		
715	822	9/30/2007	LVN		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	b, USPAT: /822	9/30/2007	LVN	

SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
inventor name search	9/24/2007	LVN
US-PGPub, USPAT: 715/822,716- 721,760,501.1,513; 725/29,39,50,91,141,151	9/24/2007	LVN
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